

Notice of References CitedApplication/Control No.
10/027,362Applicant(s)/Patent Under
Reexamination
SHIMADA ET AL.Examiner
Emanuel T. VoeltzArt Unit
2121

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------------------------|----------------|
| | A | US-4,316,251 | 02-1982 | Saito et al. | 701/36 |
| | B | US-4,408,278 | 10-1983 | Saito et al. | 165/204 |
| | C | US-5,115,418 | 05-1992 | Shimada, Akira | 318/616 |
| | D | US-5,483,438 | 01-1996 | Nishimura, Tomoyuki | 700/29 |
| | E | US-5,547,296 | 08-1996 | Iwazawa, Naotoshi | 400/322 |
| | F | US-5,719,479 | 02-1998 | Kato et al. | 318/563 |
| | G | US-5,734,242 | 03-1998 | Iwashita, Yasusuke | 318/434 |
| | H | US-6,094,602 | 07-2000 | Schade, III, William John | 700/45 |
| | I | US-6,411,461 B1 | 06-2002 | Szita, Gabor | 360/77.07 |
| | J | US-6,505,475 B1 | 01-2003 | Zugibe et al. | 62/192 |
| | K | US-6,564,110 B1 | 05-2003 | Makino et al. | 700/56 |
| | L | US-6,567,711 B1 | 05-2003 | Hosek et al. | 700/55 |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|----------|----------------|
| | N | JP401175518 A | 07-1989 | Japan | Takahash | - |
| | O | JP02001227825 A | 08-2001 | Japan | Ijiri | - |
| | P | JP02001227826 A | 08-2001 | Japan | Ijiri | - |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

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